



Bruker Nano Surface Metrology Workshop

February 8, 2012 8:30AM – 4:30PM

Marriott Courtyard Hotel, 2621 South 47th Street, Phoenix, AZ 85008
Meeting Room B

Please join us for a day of informative technical presentations and metrology system demonstrations. Space is limited. Sign up early!

RSVP to Randy.Beaubien@bruker-nano.com or rthompson@netmercury.net

Agenda

8:15 AM *Continental Breakfast Provided*

8:30 AM to 10 AM – *Technical Presentations*

Dektak-XT for Advanced Stylus Profiling Applications

Tim Ballinger – Bruker Nano

3D Surface Measurements with Bruker's ContourGT™ Optical Profiling Systems

Erik Novak, Ph.D. – Bruker Nano

10 AM to Noon – *Hands-on Sample Analysis with ContourGT-K1 & DektakXT*

Application scientists from Bruker will be available to demonstrate measurements on the Workshop metrology tools. Customer samples will also be measured.

Noon to 1 PM *Bruker will provide a light lunch*

1 PM to 4:30 PM – *Hands-on Sample Analysis with ContourGT-K1 & DektakXT*

Application scientists from Bruker will be available to demonstrate measurements on the Workshop metrology tools. Customer samples will also be measured.

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